# imall

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March 2009

SEMICONDUCTOR® FGA50N100BNT 1000V, 50A NPT-Trench IGBT CO-PAK

## **Features**

· High Speed Switching

FAIRCHILD

- Low Saturation Voltage  $: V_{CE(sat)} = 2.5 \text{ V} @ I_C = 60 \text{ A}$ •
- High Input Impedance •
- RoHS Compliant

### Applications

• UPS, PFC, I-H Jar, Induction Heater, Home Appliance.

## **General Description**

Trench insulated gate bipolar transistors (IGBTs) with NPT technology show outstanding performance in conduction and switching characteristics as well as enhanced avalanche ruggedness. These devices are well suited for UPS, PFC, I-H Jar, induction Heater and Home Appliance.

## TO-3P

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Symbol	Description		Ratings	Units	
V <sub>CES</sub>	Collector to Emitter Voltage		1000	V	
V <sub>GES</sub>	Gate to Emitter Voltage		± 25	V	
I <sub>C</sub>	Collector Current	@ T <sub>C</sub> = 25°C	50	А	
	Collector Current	@ T <sub>C</sub> = 100°C	35	А	
I <sub>CM (1)</sub>	Pulsed Collector Current		200	A	
P <sub>D</sub>	Maximum Power Dissipation	@ T <sub>C</sub> = 25°C	156	W	
' D	Maximum Power Dissipation	@ T <sub>C</sub> = 100 <sup>o</sup> C	63	W	
TJ	Operating Junction Temperature		-55 to +150	°C	
T <sub>stg</sub>	Storage Temperature Range		-55 to +150	°C	
TL	Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 seconds		300	°C	

Notes: 1: Repetitive rating : Pulse width limited by max. junction temperature

## **Thermal Characteristics**

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}(IGBT)$	Thermal Resistance, Junction to Case	-	0.8	°C/W
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient	-	40.0	°C/W

e Marking Device Pa		Package	Packaging ackage Type		Qty per Tube		Max Qty per Box	
100BNT	FGA50N100BNTTU	TO-3PN	Rail / Tube	30	30ea		-	
al Cha	racteristics of t	he IGBT	T <sub>C</sub> = 25°C unless otherwise noted					
	Parameter	-	Test Conditions	Min.	Тур.	Max.	Units	
teristics								
	to Emitter Breakdown Vo	ltage V <sub>GE</sub> =	0V, I <sub>C</sub> = 1mA	1000	-	-	V	
					-	1.0	mA	
G-E Leak	kage Current	-	$V_{GE} = \pm 25V, V_{CE} = 0V$		-	±500	nA	
		1			1			
	eshold Voltage	lo = 60	mA Vor = Vor	4 0	55	70	V	
GE(th) G-E Threshold Voltage		-				-	V	
Collector	collector to Emitter Saturation Voltage		* *		_	-	V	
at) Collector to Emitter Saturation Voltage		I <sub>C</sub> = 60	$I_{\rm C} = 60$ A, $V_{\rm GE} = 15$ V,		3.1	-	V	
baractoria	stice	I						
1				-	6000	-	pF	
Output C	apacitance		$V_{CE} = 10V$ , $V_{GE} = 0V$ , f = 1MHz		260	-	pF	
	•	t = 1MI			200	-	pF	
		I		I	1			
					24			
		V <sub>CC</sub> =	600V, I <sub>C</sub> = 60A,			-	ns	
		R <sub>G</sub> = 1	$R_{G} = 10\Omega, V_{GE} = 15V,$ Inductive Load, $T_{C} = 25^{\circ}C$			-	ns	
		Inducti				-	ns	
			V <sub>CE</sub> = 600V, I <sub>C</sub> = 60A, V <sub>GE</sub> = 15V, T <sub>C</sub> = 25°C				ns	
	-	V <sub>CE</sub> =				350	nC	
	<u> </u>	V <sub>GE</sub> =				-	nC nC	
	al Cha teristics Collector Collector G-E Leal teristics G-E Thre Collector Colle	IOOBNT FGA50N100BNTTU   al Characteristics of tl   Parameter   teristics   Collector to Emitter Breakdown Vc   Collector Cut-Off Current   G-E Leakage Current   teristics   G-E Threshold Voltage	IOUBNT FGA50N100BNTTU TO-3PN   al Characteristics of the IGBT   Parameter T   teristics Collector to Emitter Breakdown Voltage $V_{GE} = 1$ Collector Cut-Off Current $V_{CE} = 1$ G-E Leakage Current $V_{CE} = 1$ G-E Threshold Voltage $I_C = 60$ Collector to Emitter Saturation Voltage $I_C = 60$ Collector to Emitter Saturation Voltage $I_C = 60$ Collector to Emitter Saturation Voltage $I_C = 60$ Ic = 10 $I_C = 60$ Ic = 12 $I_C = 60$ Ic = 12 $I_C = 10$ Baracteristics $V_{CE} = 1$ Input Capacitance $V_{CE} = 1$ Output Capacitance $V_{CE} = 1$ Duru-On Delay Time $I_{C} = 10$ Rise Time $V_{CE} = 1$ Turn-On Delay Time $I_{C} = 10$	MarkingDevicePackageType100BNTFGA50N100BNTTUTO-3PNRail / Tubeal Characteristics of the IGBTT <sub>c</sub> = 25°C unless otherwise notedParameterTest ConditionsteristicsCollector to Emitter Breakdown Voltage $V_{GE} = 0V, I_C = 1mA$ Collector Cut-Off Current $V_{GE} = 1000V, V_{GE} = 0V$ G-E Leakage Current $V_{GE} = 1000V, V_{GE} = 0V$ teristicsG-E Threshold Voltage $I_C = 60mA, V_{CE} = V_{GE}$ Collector to Emitter Saturation VoltageI_C = 10A, $V_{GE} = 15V$ Collector to Emitter Saturation VoltageV <sub>CE</sub> = 10A, $V_{GE} = 15V$ I_C = 60A, $V_{GE} = 15V$ I_C = 10V, $V_{GE} = 0V$ , $f = 1MHz$ Turn-On Delay TimeRise TimeTurn-Off Delay TimeRise TimeTotal Gate ChargeV <sub>CE</sub> = 600V, $I_C = 60A$ , $V_{CE} = 25°C$	MarkingDevicePackageTypeQty pector100BNTFGA50N100BNTTUTO-3PNRail / Tube30al Characteristics of the IGBTT <sub>C</sub> = 25°C unless otherwise notedParameterTest ConditionsMin.teristicsCollector to Emitter Breakdown Voltage $V_{GE} = 0V, I_C = 1mA$ 1000Collector Cut-Off Current $V_{CE} = 1000V, V_{GE} = 0V$ -teristicsG-E Leakage Current $V_{GE} = 125V, V_{CE} = 0V$ teristicsG-E Threshold Voltage $I_C = 60mA, V_{CE} = V_{GE}$ 4.0 $I_C = 10A, V_{GE} = 15V$ $I_C = 60A, V_{GE} = 15V$ -Collector to Emitter Saturation Voltage $I_C = 60A, V_{GE} = 15V$ - $I_C = 60A, V_{GE} = 15V, T_C = 125°C$ $I_C = 102, V_{GE} = 15V, T_C = 125°C$ -haracteristicsInput Capacitance $V_{CE} = 10V, V_{GE} = 0V, f = 1MHz$ -Parameteristics $V_{CC} = 600V, I_C = 60A, P_G = 15V, I_C = 100, P_G = 15V, I_C = 25°C$ -Turn-On Delay Time $V_{CE} = 600V, I_C = 60A, P_G = 15V, I_C = 25°C$ -Turn-Off Delay Time $V_{CE} = 600V, I_C = 60A, P_G = 15V, I_C = 25°C$ -Fall Time $V_{CE} = 600V, I_C = 60A, P_G = 15V, I_C = 25°C$ -Gate to Emitter Charge $V_{CE} = 600V, I_C = 60A, P_G = 15V, I_C = 25°C$ -	MarkingDevicePackageTypeQty per Tube100BNTFGA50N100BNTTUTO-3PNRail / Tube30eaal Characteristics of the IGBTTe 25°C unless otherwise notedParameterTest ConditionsMin.Typ.teristicsCollector to Emitter Breakdown Voltage $V_{GE} = 0V, I_C = 1mA$ 1000-Collector Cut-Off Current $V_{CE} = 1000V, V_{GE} = 0V$ G-E Leakage Current $V_{CE} = 100V, V_{CE} = 0V$ teristicsG-E Threshold Voltage $I_C = 60mA, V_{CE} = V_{GE}$ 4.05.5Collector to Emitter Saturation Voltage $I_C = 60mA, V_{CE} = 15V$ -1.5Collector to Emitter Saturation Voltage $I_C = 60A, V_{GE} = 15V$ -3.1haracteristicsInput Capacitance $V_{CE} = 10V, V_{GE} = 0V, f = 15V, T = 25°C$ -260Reverse Transfer Capacitance $V_{CC} = 600V, I_C = 60A, R = 15V, I = 25°C$ -34Rise Time $V_{CC} = 600V, I_C = 60A, R = 15V, I = 25°C$ -68Turn-On Delay Time $Iuncurve Load, T_C = 25°C$ -66Total Gate Charge $V_{CE} = 600V, I_C = 60A, V_{CE} = 60A, Q = 15V, I = 25°C$ -243Fall Time $V_{CE} = 600V, I_C = 60A, Q = 15V, I = 25°C$ -243	MarkingDevicePackageTypeOty per Tubeper100BNTFGA50N100BNTTUTO-3PNRail / Tube30eaal Characteristics of the IGBTTest ConditionsMin.Typ.Max.teristicsCollector to Emitter Breakdown Voltage $V_{GE} = 0V, I_C = 1mA$ 1000Collector to Emitter Breakdown Voltage $V_{GE} = 0V, I_C = 1mA$ 1000Collector Cut-Off Current $V_{CE} = 1000V, V_{GE} = 0V$ 1.0G-E Leakage Current $V_{CE} = 100V, V_{CE} = 0V$ ±500teristicsG-E Threshold Voltage $I_C = 60mA, V_{CE} = V_{GE}$ 4.05.57.0Ic = 10A. V_{GE} = 15V-1.51.8I_C = 60A, V_{GE} = 15V-1.5Collector to Emitter Saturation Voltage $I_C = 60A, V_{GE} = 15V, I_C = 10V, V_{GE} = 15V, I_C = 125°C-3.1-haracteristicsInput CapacitanceV_{CE} = 10V, V_{GE} = 0V, I_C = 125°C-260-Turn-On Delay TimeTurn-On Delay TimeV_{CC} = 600V, I_C = 60A, V_{GE} = 15V, I_C = 25°C-34-Fail TimeV_{CE} = 600V, I_C = 60A, V_{GE} = 15V, I_C = 25°C-243-Turn-Off Delay TimeV_{CE} = 600V, I_C = 60A, V_{GE} = 15V, I_C = 25°C-257350Gate to Emitter ChargeV_{CE} = 600V, I_C = 60A, V_{GE} = 15V, I_C = 25°C-45-$	

FGA50N100BNT 1000V, 50A NPT-Trench IGBT CO-PAK

## Typical Performance Characteristics



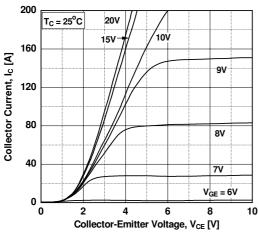


Figure 3. Typical Saturation Voltage Characteristics

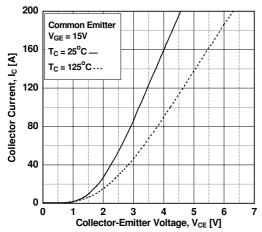
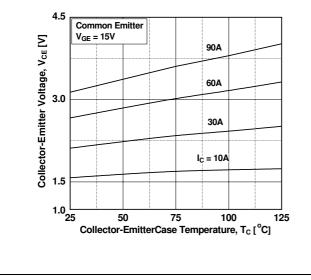


Figure 5. Saturation Voltage vs. Case Temperature at Variant Current Level



**Figure 2. Typical Output Characteristics** 

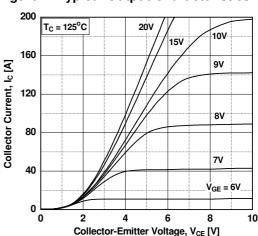


Figure 4. Transfer Characteristics

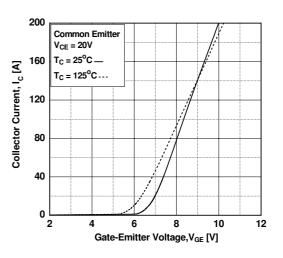
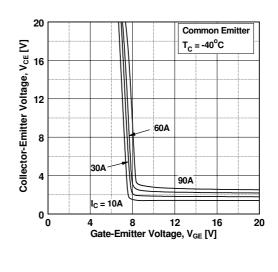
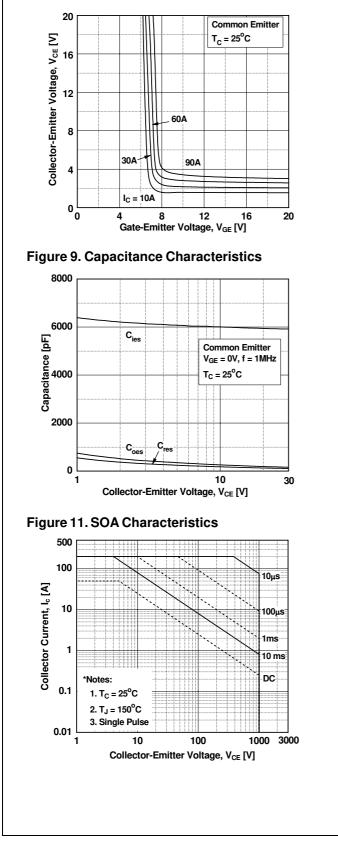


Figure 6. Saturation Voltage vs. V<sub>GE</sub>





**Typical Performance Characteristics** 

Figure 7. Saturation Voltage vs. V<sub>GE</sub>

### Figure 8. Saturation Voltage vs. V<sub>GE</sub>

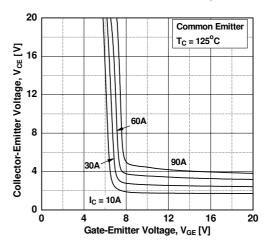
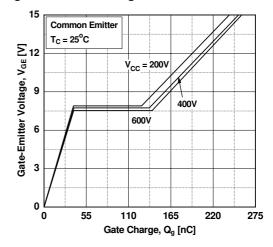
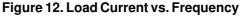
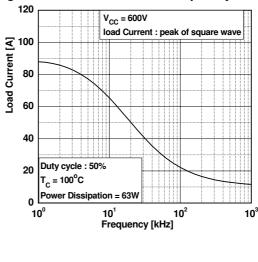


Figure 10. Gate charge Characteristics







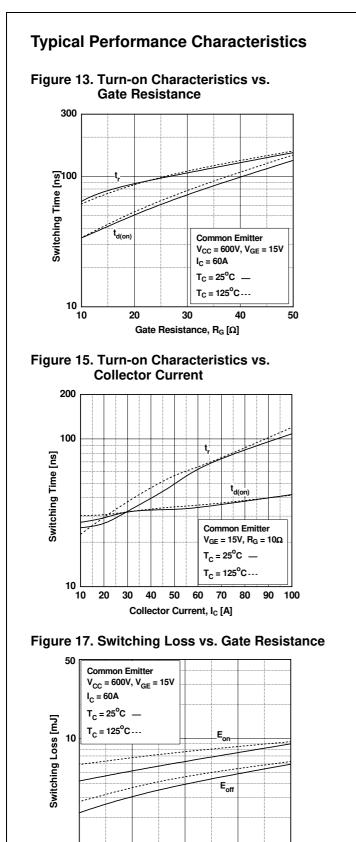
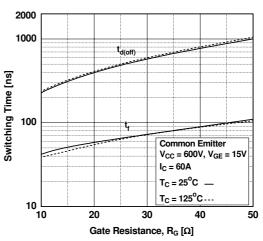
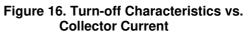
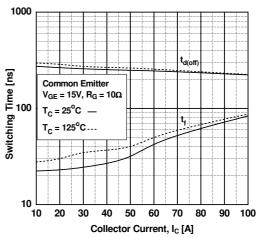
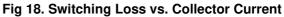


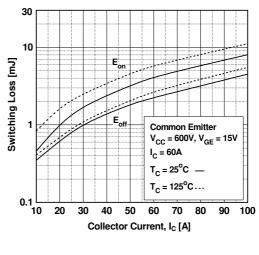
Figure 14. Turn-off Characteristics vs. Gate Resistance











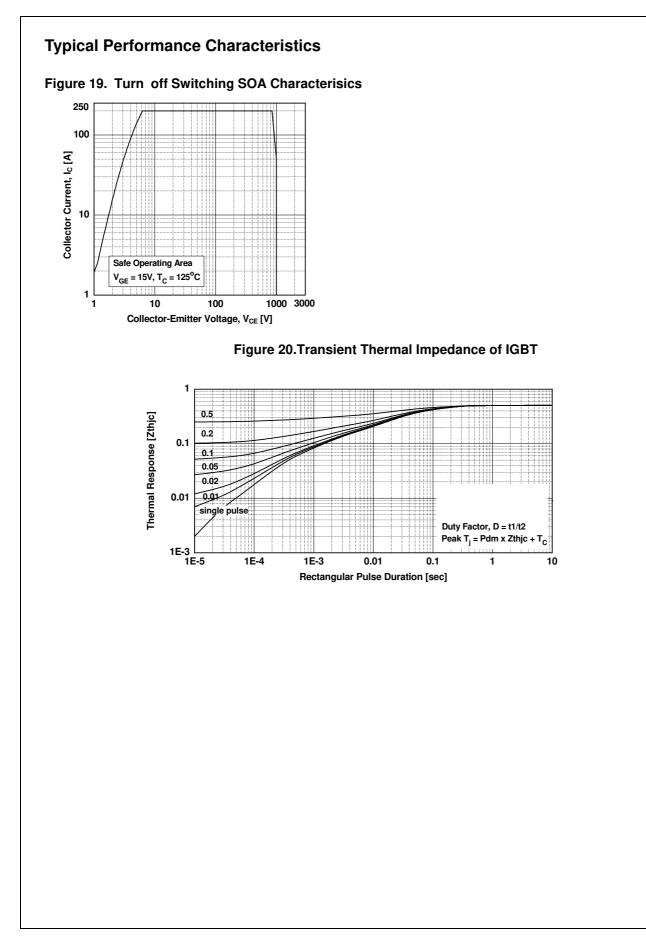
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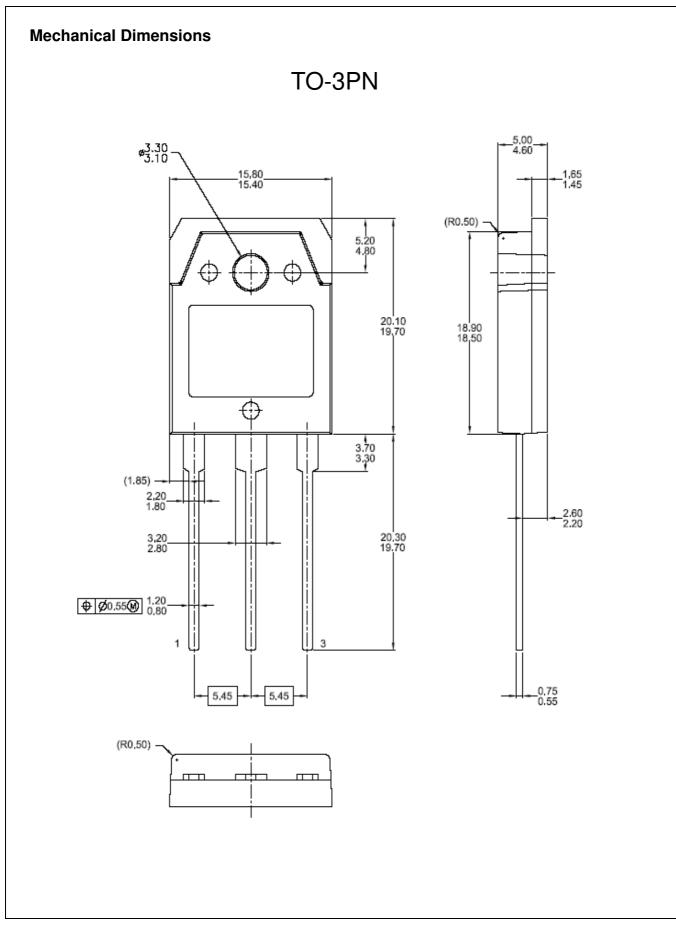
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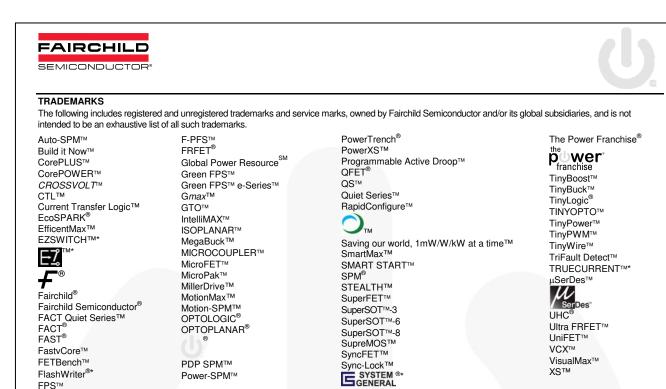
Gate Resistance,  $R_G [\Omega]$ 

40

50







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